

Notice of References Cited	Application/Control No. 10/527,684		Applicant(s)/Patent Under Reexamination DE DINECHIN ET AL.	
	Examiner Lynne Edmondson		Art Unit 1725	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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*	B	US-6,555,779	04-2003	Obana et al.	219/121.63
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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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